

More Precision

reflectCONTROL Compact // Inspection system for reflecting surfaces



Inspection system for reflecting surfaces



reflectCONTROL Compact

- High speed, high resolution measurement on surfaces up to 265 x 110mm
- 2 versions for defect recognition or 3D reconstruction
- Proven technology for offline inspection and integration into processing lines
- Interfaces: USB, VGA, Ethernet, Digital I/O

Surface inspection and defect recognition

In many areas, ever-increasing requirements are placed on the quality and the appearance of a surface. Particularly with reflecting surfaces, faultless production is expected.

reflectCONTROL Compact is designed specifically for the inspection of shiny surfaces. The system projects a striped pattern onto the measurement object. Defects on the surface cause deviations from the striped pattern, which are recorded by cameras and evaluated by software. The fully integrated system is available in two versions that each provides different measuring fields. The 2D version is used for pure defect recognition on reflecting surfaces.

The 3D version allows for an additional measurement of reflecting surfaces at sub-micrometer accuracies. This device is also used in individual operations (e.g. laboratories) as well as directly in production lines.

All-in-one

All components are integrated in a compact device. The housing includes a monitor for the striped pattern protection, as well as two cameras. In order to avoid interferences from ambient light, the measuring field can be darkened on all four sides. The legs are height-adjustable which enables to balance different component heights. This operation is performed via touch screen or mouse and keyboard, which can be connected via USB.

reflectCONTROL Compact can be integrated into production lines. A digital I/O interface enables triggering and alarms. If the device is installed in a difficult-to-access place, an external operating monitor can be connected via VGA.

The pre-installed operating and evaluation software of the 2D version shows surface defects. The 3D version provides a point cloud. The data obtained can be treated in the image processing programs.

Free test measurements

In order to objectively appraise your measurement task, Micro-Epsilon offers non-binding inspections of your boundary samples. Please feel free to contact us!

Application examples:

- Inspection of touchscreens for smartphones and tablets
- Default detection on car attachments and interior components
- Measurement of telescope mirrors and lenses



Phase image



Defect detection



3D reconstruction of the surface



Relative air humidity

10 ... 80% in declared temperature without condensation











High performance sensors made by Micro-Epsilon



Sensors and systems for displacement and position



Optical micrometers, fibre optics sensors and fibre optics



Sensors and measurement devices for non-contact temperature measurement



Colour recognition sensors, LED analyzers and colour online spectrometer



2D/3D profile sensors (laser scanner)



Measurement and inspection systems



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